

HFB1N70S

700V N-Channel MOSFET

FEATURES

- Originative New Design
- Superior Avalanche Rugged Technology
- Robust Gate Oxide Technology
- Very Low Intrinsic Capacitances
- Excellent Switching Characteristics
- Unrivalled Gate Charge : 4.5 nC (Typ.)
- Extended Safe Operating Area
- Lower $R_{DS(ON)}$: 14 Ω (Typ.) @ $V_{GS}=10V$
- 100% Avalanche Tested

$$BV_{DSS} = 700 \text{ V}$$

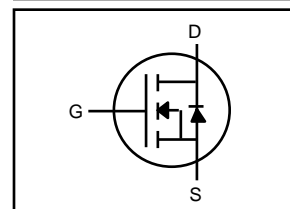
$$R_{DS(on) \text{ typ}} = 14.0 \ \Omega$$

$$I_D = 0.3 \text{ A}$$

TO-92



1.Gate 2. Drain 3. Source



Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Value	Units
V_{DSS}	Drain-Source Voltage	700	V
I_D	Drain Current – Continuous ($T_C = 25^\circ\text{C}$)	0.3	A
	Drain Current – Continuous ($T_C = 100^\circ\text{C}$)	0.18	A
I_{DM}	Drain Current – Pulsed (Note 1)	1.2	A
V_{GS}	Gate-Source Voltage	± 30	V
E_{AS}	Single Pulsed Avalanche Energy (Note 2)	33	mJ
I_{AR}	Avalanche Current (Note 1)	0.3	A
E_{AR}	Repetitive Avalanche Energy (Note 1)	0.25	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.5	V/ns
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	2.5	W
	– Derate above 25°C	0.02	W/ $^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ\text{C}$

* Drain current limited by junction temperature

Thermal Resistance Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JL}$	Junction-to-Lead	--	50	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient	--	140	

Electrical Characteristics $T_C=25\text{ }^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
On Characteristics						
V_{GS}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	2.5	--	4.5	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\ \text{V}, I_D = 0.15\ \text{A}$	--	14	17.5	Ω
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\ \text{V}, I_D = 250\ \mu\text{A}$	700	--	--	V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250\ \mu\text{A}$, Referenced to $25\text{ }^\circ\text{C}$	--	0.65	--	$\text{V}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 700\ \text{V}, V_{GS} = 0\ \text{V}$	--	--	1	μA
		$V_{DS} = 560\ \text{V}, T_C = 125\text{ }^\circ\text{C}$	--	--	10	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30\ \text{V}, V_{DS} = 0\ \text{V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30\ \text{V}, V_{DS} = 0\ \text{V}$	--	--	-100	nA
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS} = 25\ \text{V}, V_{GS} = 0\ \text{V},$ $f = 1.0\ \text{MHz}$	--	--	175	pF
C_{oss}	Output Capacitance		--	--	30	pF
C_{riss}	Reverse Transfer Capacitance		--	--	5	pF
Switching Characteristics						
$t_{d(on)}$	Turn-On Time	$V_{DS} = 350\ \text{V}, I_D = 0.8\ \text{A},$ $R_G = 25\ \Omega$ (Note 4,5)	--	12	30	ns
t_r	Turn-On Rise Time		--	40	140	ns
$t_{d(off)}$	Turn-Off Delay Time		--	20	60	ns
t_f	Turn-Off Fall Time		--	30	80	ns
Q_g	Total Gate Charge	$V_{DS} = 560\ \text{V}, I_D = 0.8\ \text{A},$ $V_{GS} = 10\ \text{V}$ (Note 4,5)	--	--	6.0	nC
Q_{gs}	Gate-Source Charge		--	--	--	nC
Q_{gd}	Gate-Drain Charge		--	--	--	nC
Source-Drain Diode Maximum Ratings and Characteristics						
I_S	Continuous Source-Drain Diode Forward Current		--	--	0.3	A
I_{SM}	Pulsed Source-Drain Diode Forward Current		--	--	1.2	
V_{SD}	Source-Drain Diode Forward Voltage	$I_S = 0.3\ \text{A}, V_{GS} = 0\ \text{V}$	--	--	1.4	V
t_{rr}	Reverse Recovery Time	$I_S = 0.8\ \text{A}, V_{GS} = 0\ \text{V}$ $di/dt = 100\ \text{A}/\mu\text{s}$ (Note 4)	--	190	--	ns
Q_{rr}	Reverse Recovery Charge		--	0.53	--	μC

Notes ;

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $L=96\text{mH}, I_{AS}=0.8\text{A}, V_{DD}=50\text{V}, R_G=25\Omega$, Starting $T_J=25\text{ }^\circ\text{C}$
3. $I_{SD} \leq 0.3\text{A}, di/dt \leq 200\text{A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$, Starting $T_J=25\text{ }^\circ\text{C}$
4. Pulse Test : Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
5. Essentially Independent of Operating Temperature